

Notice of References Cited	Application/Control No. 10/593,470	Applicant(s)/Patent Under Reexamination MIYAMOTO ET AL.	
	Examiner JOHN K. KIM	Art Unit 2834	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,441,515	08-2002	Shimura, Yoshiki	310/12
*	C	US-5,801,462	09-1998	Yagoto et al.	310/12
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	01037334.pdf : Jong et al (2002 IEEE publication, "Smart Silicon Sensor – Example of Hall Effect Sensors")
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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